

Description

Q-Tech's surface-mount QT92 Series oscillators consist of an IC 5Vdc, 3.3Vdc, 2.5Vdc, 1.8Vdc clock square wave generator and an AT high-precision quartz crystal built in a rugged surface-mount ceramic miniature package. It was designed to be replaceable and retrofitable into the footprint of a 7 x 5mm COTS oscillator.

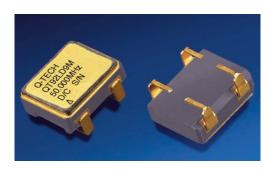
Features

- · Made in the USA
- ECCN: EAR99
- DFARS 252-225-7014 Compliant: Electronic Component Exemption
- Drop in replacement for 7 x 5mm COTS oscillator with built-in by-pass capacitor
- Available as QPL MIL-PRF-55310/37, /38, /39 and /40
- Able to meet 36000G shock per ITOP 1-2-601
- Broad frequency range from 15kHz to 160MHz
- ACMOS, HCMOS, TTL, LVHCMOS, Differential LVPECL or LVDS logic
- Tri-State Output Option (D)
- Hermetically sealed ceramic SMD package
- Fundamental and 3rd Overtone designs
- · Low phase noise
- · Custom designs available
- Q-Tech does not use pure lead or pure tin in its products
- RoHS compliant

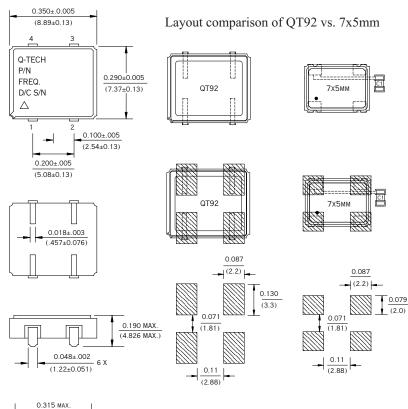


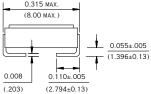
Applications

- Designed to meet today's requirements for low voltage applications
- Wide military clock applications
- Gun launched munitions and systems
- · Benign space environments
- · Smart munitions
- Navigation
- · Industrial controls
- · Microcontroller driver
- Down-hole applications up to +200°C



Package Outline and Pin Connections Dimensions are in inches (mm)





| Pin No. | Function |
|---------|----------------|
| 1 | TRISTATE or NC |
| 2 | GND/CASE |
| 3 | OUTPUT |
| 4 | VDD |

Package Information

- Package material: 91% AL₂O₃
- Lead material: Kovar
- Lead finish: Gold Plated: $50\mu \sim 80\mu$ inches Nickel Underplate: $100\mu \sim 250\mu$ inches
- Weight: 0.6g typ., 3.0g max.



Electrical Characteristics

| Parameters | QT92AC | QT92HC | QT92T | QT92L | QT92N | QT92R |
|--|---|-----------------------------|--|--|--|--|
| Output frequency range (Fo) | 500kHz — 85.000MHz | 15kHz — 85.000MHz(*) | 500kHz — 85.000MHz | 15kHz — 160.000MHz (*) | 125.000kHz — 133.000MHz | 125.000kHz — 100.000MHz |
| Supply voltage (Vdd) | 5.0Vdc ± 10% | | 3.3Vdc ± 10% | 2.5Vdc ± 10% | 1.8Vdc ± 10% | |
| Maximum Applied Voltage (Vdd max.) | -0.5 to +7.0Vdc | | | -0.5 to +5.0Vdc | | |
| Frequency stability (ΔF/ΔT) | | | | See Option codes | | |
| Operating temperature (Topr) | See Option codes | | | | | |
| Storage temperature (Tsto) | -62°C to + 125°C | | | | | |
| Operating supply current (Idd) (No Load) | 20 mA max 15kHz ~< 16MHz 25 mA max 16MHz ~< 32MHz 35 mA max 32MHz ~< 60MHz 45 mA max 60MHz ~≤ 85MHz | | | $\begin{array}{lll} 3 \text{ mA max.} & -15 \text{kHz} & \sim < 500 \text{kHz} \\ 6 \text{ mA max.} & -500 \text{kHz} & \sim < 16 \text{MHz} \\ 10 \text{ mA max.} & -16 \text{MHz} & \sim < 32 \text{MHz} \\ 20 \text{ mA max.} & -32 \text{MHz} & \sim < 60 \text{MHz} \\ 30 \text{ mA max.} & -60 \text{MHz} & \sim < 100 \text{MHz} \\ 40 \text{ mA max.} & -100 \text{MHz} & \sim < 130 \text{MHz} \\ 50 \text{ mA max.} & -130 \text{MHz} & \sim \le 160 \text{MHz} \end{array}$ | 3 mA max 125kHz ~< 500kHz 6 mA max 500kHz ~< 40MHz 15 mA max 40MHz ~< 60MHz 25 mA max 60MHz ~< 85MHz 35 mA max 85MHz ~≤ 133MHz | 4 mA max 125kHz ~< 40MHz 10 mA max 40MHz ~< 50MHz 20 mA max 50MHz ~< 85MHz 25 mA max 85MHz ~ ≤ 100MHz |
| Symmetry (50% of ouput waveform or 1.4Vdc for TTL) | $45/55\%$ max 15 kHz \sim < 15 MHz $40/60\%$ max 15 MHz \sim \leq 85 MHz (Tighter symmetry available) | | $45/55\%$ max 15 kHz \sim < 15 MHz $40/60\%$ max 15 MHz \sim ≤ 160 MHz (Tighter symmetry available) | 45/55% max 125kHz ~ < 15MHz 40/60% max 15MHz ~ ≤ 133MHz (Tighter symmetry available) | 45/55% max 125kHz~ < 15MHz 40/60% max 15MHz ~ ≤ 100MHz (Tighter symmetry available) | |
| Rise and Fall times (with typical load) | 200ns max. Fo \leq 345.6kHz 8ns max. Fo 345.6kHz \sim \leq 20MHz 5ns max. Fo 20MHz \sim \leq 50MHz 7ns max 20MHz \sim \leq 40MHz (50pF Load) 3ns max. Fo $>$ 50MHz (Measured from 10% to 90% CMOS or from 0.8V to 2.0V TTL) | | 200ns max. Fo $<$ 345.6kHz 6ns max. Fo 345.6kHz \sim \le 20MHz 4ns max. Fo 20MHz \sim \le 50MHz 3ns max. Fo $>$ 50MHz 7ns max 50pF Load (Measured from 10% to 90%) | | | |
| Output Load | 15pF // 10kohms 50pF max. or 10TTL for (Fo < 40MHz) 30pF max. or 6TTL for (Fo \geq 40MHz) | 15pF // 10kohms (2LSTTL) | 10TTL (Fo < 60MHz) 6TTL (F o ≥ 60MHz) | 15pF // 10kohms $(30pF \ max. \ available \ for \ F \leq 40MHz)$ | 15pF // 10kohms | |
| Start-up time (Tstup) | 10ms max. | | | 5ms max. | | |
| Output voltage (Voh/Vol) | 0.9 x Vdd min.; 0.1 x Vdd max. 2.4V min.; 0.4V max. | | | 0.9 x Vdd min.; 0.1 x Vdd max. | | |
| Output Current (Ioh/Iol) | ± 24mA max. | ± 16mA max. | -1.6 mA/TTL +40 μA/TTL | ± 8mA max. | | |
| Enable/Disable Tristate function Pin 1 | $ \begin{array}{ll} VIH \geq 4.0 V \ Oscillation; & VIH \geq 2.2 V \ Oscillation; \\ VIL \leq 0.8 V \ High \ Impedance & VIL \leq 0.8 V \ High \ Impedance \end{array} $ | | $VIH \ge 2.0V$ Oscillation; $VIL \le 0.5V$ High Impedance | VIH \geq 1.75V Oscillation; VIL \leq 0.5V High Impedance | VIH \geq 1.26V Oscillation; VIL \leq 0.5V High Impedance | |
| Jitter RMS 1σ (at 25°C) | 8ps typ < 40MHz 5ps typ ≥ 40MHz | | | 15ps typ < 40MHz 8ps typ ≥ 40MHz | | |
| Aging (at 70°C) | ± 5ppm max. first year / ± 2ppm max. per year thereafter | | | | | |

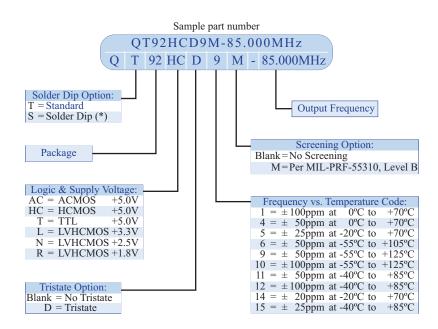
^(*) Some frequencies lower than 500kHz may not be available with tristate function

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Ordering Information



(*) Hot Solder Dip Sn60/Pb40 per MIL-PRF 55310 is optional for an additional cost

Frequency stability vs. temperature codes may not be available in all frequencies.

For Non-Standard requirements, contact Q-Tech Corporation at Sales@Q-Tech.com

Packaging Options

- Standard packaging in anti-static plastic tube (60 pcs/tube)
- Tape and Reel (800 pcs/reel) is available for an additional charge.

Other Options Available For An Additional Charge

• P. I. N. D. test (MIL-STD 883, Method 2020)

Specifications subject to change without prior notice.

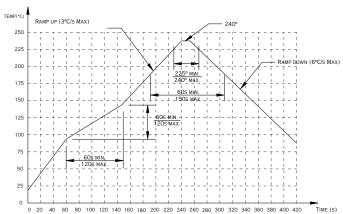


Reflow Profile

The five transition periods for the typical reflow process are:

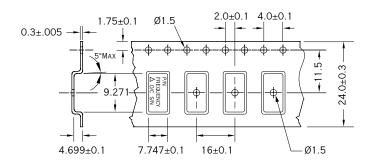
- · Preheat
- Flux activation
- · Thermal equalization
- · Reflow
- · Cool down

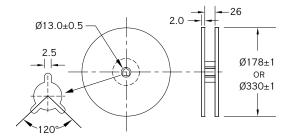




Embossed Tape and Reel Information For QT92

FEEDING (PULL) DIRECTION ——





Dimensions are in mm. Tape is compliant to EIA-481-A.

Reel size vs. quantity:

| Reel size (Diameter in mm) | Qty per reel (pcs) |
|----------------------------|--------------------|
| 178 | 150 |
| 330 | 800 |

Environmental Specifications

Q-Tech Standard Screening/QCI (MIL-PRF55310) is available for all of our QT92 Products. Q-Tech can also customize screening and test procedures to meet your specific requirements. The QT92 product is designed and processed to exceed the following test conditions:

| Environmental Test | Test Conditions |
|---------------------------------|---|
| Temperature cycling | MIL-STD-883, Method 1010, Cond. B |
| Constant acceleration | MIL-STD-883, Method 2001, Cond. A, Y1 |
| Seal: Fine and Gross Leak | MIL-STD-883, Method 1014, Cond. A and C |
| Burn-in | 160 hours, 125°C with load |
| Aging | 30 days, 70°C, ±1.5ppm max |
| Vibration sinusoidal | MIL-STD-202, Method 204, Cond. D |
| Shock, non operating | MIL-STD-202, Method 213, Cond. I (See Note 1) |
| Thermal shock, non operating | MIL-STD-202, Method 107, Cond. B |
| Ambient pressure, non operating | MIL-STD-202, 105, Cond. C, 5 minutes dwell time minimum |
| Resistance to solder heat | MIL-STD-202, Method 210, Cond. C |
| Moisture resistance | MIL-STD-202, Method 106 |
| Terminal strength | MIL-STD-202, Method 211, Cond. C |
| Resistance to solvents | MIL-STD-202, Method 215 |
| Solderability | MIL-STD-202, Method 208 |
| ESD Classification | MIL-STD-883, Method 3015, Class 1 HBM 0 to 1,999V |
| Moisture Sensitivity Level | J-STD-020, MSL=1 |

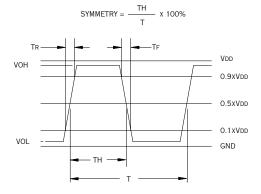
Note 1: Additional shock results successfully passed on standard QT88 family 16MHz, 20MHz, 24MHz, 40MHz, and 80MHz

- Shock 850g peak, half-sine, 1 ms duration (MIL-STD-202, Method 213, Cond. D modified)
- Shock 1,500g peak, half-sine, 0.5ms duration (MIL-STD-883, Method 2002, Cond. B)
- Shock 36,000g peak, half-sine, 0.12 ms duration

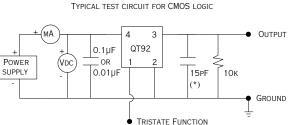
Please contact Q-Tech for higher shock requirements



Output Waveform (Typical)



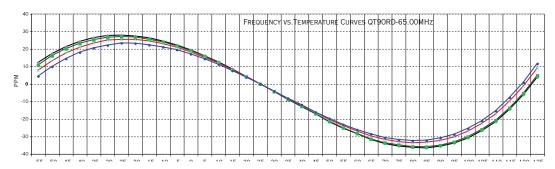
Test Circuit



(*) CL INCLUDES PROBE AND JIG CAPACITANCE

The Tristate function on pin 1 has a built-in pull-up resistor typical $50k\Omega$, so it can be left floating or tied to Vdd without deteriorating the electrical performance.

Frequency vs. Temperature Curve



Thermal Characteristics

The heat transfer model in a hybrid package is described in figure 1.

Heat spreading occurs when heat flows into a material layer of increased cross-sectional area. It is adequate to assume that spreading occurs at a 45° angle.

The total thermal resistance is calculated by summing the thermal resistances of each material in the thermal path between the device and hybrid case.

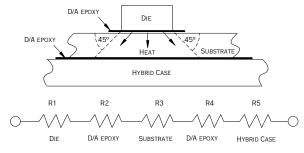
$$RT = R1 + R2 + R3 + R4 + R5$$

The total thermal resistance RT (see figure 2) between the heat source (die) to the hybrid case is the Theta Junction to Case (Theta JC) in C/W.

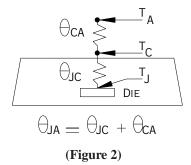
- Theta junction to case (Theta JC) for this product is 30°C/W.
- Theta case to ambient (Theta CA) for this part is 100°C/W.
- Theta Junction to ambient (Theta JA) is 130°C/W.

Maximum power dissipation PD for this package at 25°C is:

- PD(max) = (TJ (max) TA)/Theta JA
- With TJ = 175°C (Maximum junction temperature of die)
- PD(max) = (175 25)/130 = 1.15W



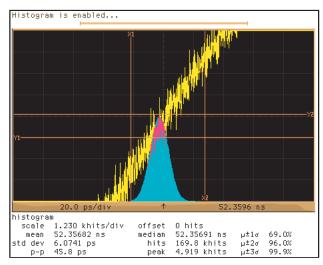
(Figure 1)





Period Jitter

As data rates increase, effects of jitter become critical with its budgets tighter. Jitter is the deviation of a timing event of a signal from its ideal position. Jitter is complex and is composed of both random and deterministic jitter components. Random jitter (RJ) is theoretically unbounded and Gaussian in distribution. Deterministic jitter (DJ) is bounded and does not follow any predictable distribution. DJ is also referred to as systematic jitter. A technique to measure period jitter (RMS) one standard deviation (1σ) and peak-to-peak jitter in time domain is to use a high sampling rate (>8G samples/s) digitizing oscilloscope. Figure shows an example of peak-to-peak jitter and RMS jitter (1σ) of a QT92ND-100MHz, at 2.5Vdc.



RMS jitter (1σ) : 6.07ps

Peak-to-peak jitter: 45.8ps

Phase Noise and Phase Jitter Integration

Phase noise is measured in the frequency domain, and is expressed as a ratio of signal power to noise power measured in a 1Hz bandwidth at an offset frequency from the carrier, e.g. 10Hz, 100Hz, 1kHz, 10kHz, 100kHz, etc. Phase noise measurement is made with an Agilent E5052A Signal Source Analyzer (SSA) with built-in outstanding low-noise DC power supply source. The DC source is floated from the ground and isolated from external noise to ensure accuracy and repeatability.

In order to determine the total noise power over a certain frequency range (bandwidth), the time domain must be analyzed in the frequency domain, and then reconstructed in the time domain into an rms value with the unwanted frequencies excluded. This may be done by converting L(f) back to $S\varphi(f)$ over the bandwidth of interest, integrating and performing some calculations.

| Symbol | Definition |
|--|--|
| $\int \mathcal{L}(\mathbf{f})$ | Integrated single side band phase noise (dBc) |
| S\phi (f)=(180/\Pi)x\sqrt{2}\frac{\int_L(f)df}{} | Spectral density of phase modulation, also known as RMS phase error (in degrees) |
| RMS jitter = $S\phi (f)/(fosc.360^\circ)$ | Jitter(in seconds) due to phase noise. Note $S\phi\left(f\right)$ in degrees. |

The value of RMS jitter over the bandwidth of interest, e.g. 10kHz to 20MHz, 10Hz to 20MHz, represents 1 standard deviation of phase jitter contributed by the noise in that defined bandwidth.

Figure below shows a typical Phase Noise/Phase jitter of a QT92HCD, 5.0Vdc, 40MHz clock at offset frequencies 10Hz to 5MHz, and phase jitter integrated over the bandwidth of 12kHz to 1MHz.

